Search Notes

Application	/Control No.
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10/822,522

HSHIEH ET AL.

Applicant(s)/Patent under Reexamination

Examiner

Charles R. Kasenge

2125

SEARCHED				
Class	Subclass	Date	Examiner	
700	90	7/22/2006	СК	
	95			
	96			
	99			
	108			
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	110			
705	7			
	8			
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	28			
	29			
340	540			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST; terms: (semiconductor with (fabrication production manufacturing)), lot, MES, WIP, yield, (ship\$4 deliver\$3)	7/22/2006	ск
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